

# APN229

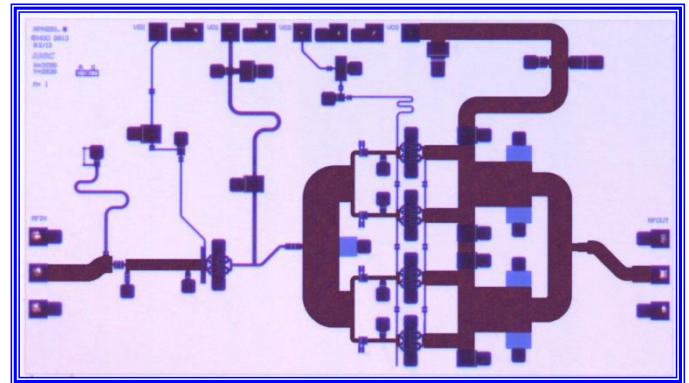
## 27 – 31 GHz

### GaN Power Amplifier

**\* PLEASE REFER TO GENERAL CHIP DIAGRAMS FOR TAB DIMENSIONING AND BONDING \***

### PRODUCT DESCRIPTION

The APN229 monolithic GaN HEMT amplifier is a broadband, two-stage power device, designed for use in SATCOM Terminals and point-to-point digital radios. To ensure rugged and reliable operation, HEMT devices are fully passivated. Both bond pad and backside metallization are Au-based that is compatible with epoxy and eutectic die attach methods.



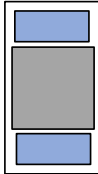


**X= 3.65 mm; Y= 2.03 mm**

### APPLICATIONS

- Point-to-Point Digital Radios
- Point-to-Multipoint Digital Radios
- SatCom Terminals

### PRODUCT OPTIONS

OPTION	FIGURE	PART #
BARE DIE		APN229
BARE DIE + TAB		APN229TAB
BARE DIE + TAB + CAPACITORS		APN229TABC

### PRODUCT FEATURES

- RF frequency: 27 to 31 GHz
- Linear Gain: 20 dB typ.
- Psat: 39 dBm typ.
- Die Size: 7.41 sq. mm.
- 0.2um GaN HEMT Process
- 4 mil SiC substrate
- DC Power: 28 VDC @ 600 mA

### EXPORT INFORMATION

ECCN: 3A001.b.2.c

HTS (Schedule B) code: 8542.33.0001



[www.ngc.com](http://www.ngc.com)

[www.ngc.com/what-we-do/microelectronics-space-park/](http://www.ngc.com/what-we-do/microelectronics-space-park/)

Phone: (310) 814-5000 • Fax: (310) 812-7011 • Email: [asmpsales@ngc.com](mailto:asmpsales@ngc.com)  
Approved for Public Release: NG24-1054. © 2024 Northrop Grumman Systems Corporation

© Northrop Grumman Systems Corporation  
Preliminary Information: The data contained in this document describes new products in the sampling or preproduction phase of development and is for information only. Northrop Grumman reserves the right to change without notice the characteristics data and other specifications as they apply to this product. The product represented by this datasheet is subject to the U.S. Export Law as contained in the EAR regulations.

**NORTHROP  
GRUMMAN**

# APN229

## 27 – 31 GHz

### GaN Power Amplifier

#### ABSOLUTE MAXIMUM RATINGS

Parameter	Value	Unit
Drain Voltage	28	V
Gate Voltage Range	-8 to 0	V
Drain Current	750	mA
Gate Current	0.3	mA
Power Dissipation*	21	W
Soldering Temperature	320	°C

\*7W/mm of gate periphery

#### RECOMMENDED OPERATING CONDITIONS

Parameter	Value	Unit
Drain Voltage Range	20 - 26	V
Gate Voltage Range	-5 to -3	V
Stg 1 Drain Current (Idq)	120	mA
Stg 2 Drain Current (Idq)	120 - 480	mA

#### ELECTRICAL SPECIFICATIONS

Parameter	Min	Typical	Max	Unit
Operational Frequency	27		31	GHz
<b>Small Signal at 28V</b>				
Small Signal Linear Gain	19		20	dB
Input Return Loss	-25		-12	dB
Output Return Loss	-28		-12	dB
<b>On-Wafer Pulsed Power at 28V</b>				
Psat (at 26 dBm)	38.8	39.5	40.5	dBm
Power Gain (at 26 dBm)	12.8	13.5	14.5	dB
PI <sub>db</sub>	38.7	39.2	40.2	dBm
PAE (at 26 dBm)	27.9	29.7	34.7	%
Max PAE	28.3	30	35	%
<b>Fixtured CW at 28V, 25°C Case Temp</b>				
Psat (at 22 dBm)	38	38.8	39	dBm
Power Gain (at 22 dBm)	15	16.8	17	dB
PAE (at 22 dBm)	29.2	32	32.7	%
Max PAE	29.5		33	%
Drain Voltage		28		V
Stage 1 Gate Voltage		-4.550		V
Stage 2 Gate Voltage		-4.490		V
Stage 1 Idq		120		mA
Stage 2 Idq		480		mA

Page 2

[www.ngc.com](http://www.ngc.com)

[www.ngc.com/what-we-do/microelectronics-space-park/](http://www.ngc.com/what-we-do/microelectronics-space-park/)

Phone: (310) 814-5000 • Fax: (310) 812-7011 • Email: [asmpsales@ngc.com](mailto:asmpsales@ngc.com)

Approved for Public Release: NG24-1054. © 2024 Northrop Grumman Systems Corporation

© Northrop Grumman Systems Corporation  
Preliminary Information: The data contained in this document describes new products in the sampling or preproduction phase of development and is for information only. Northrop Grumman reserves the right to change without notice the characteristics data and other specifications as they apply to this product. The product represented by this datasheet is subject to the U.S. Export Law as contained in the EAR regulations.

**NORTHROP  
GRUMMAN**

# APN229

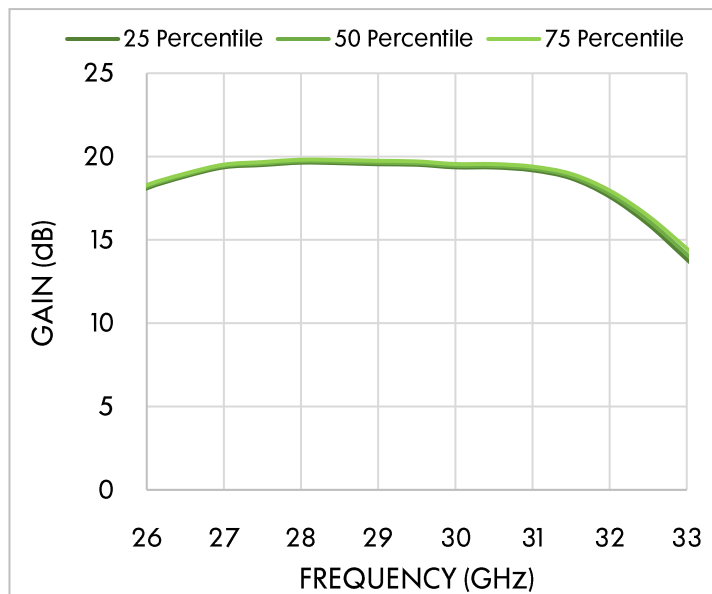
## 27 – 31 GHz

### GaN Power Amplifier

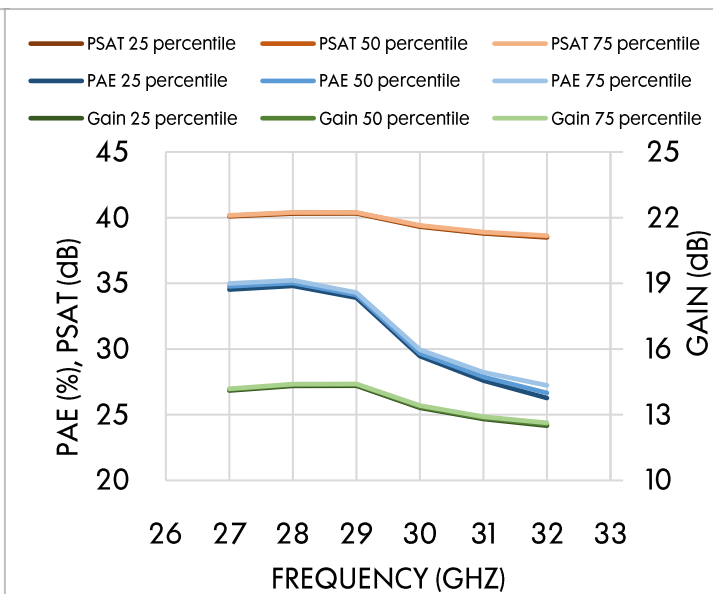
Pulsed On wafer measured Performance Characteristics (Typical Performance at 25°C)

Vd= 28.0 V, Id1+Id1a = 120 mA, Id2+Id2a = 480 mA. \*

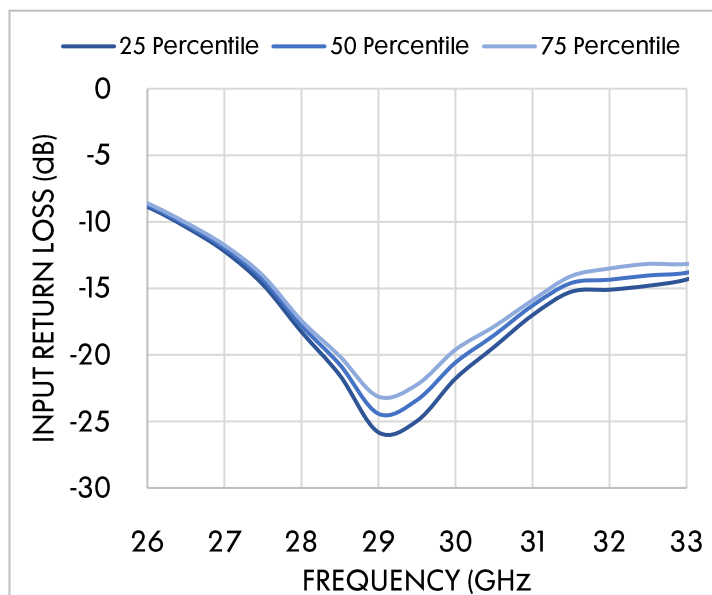
#### Small Signal Gain vs. Frequency



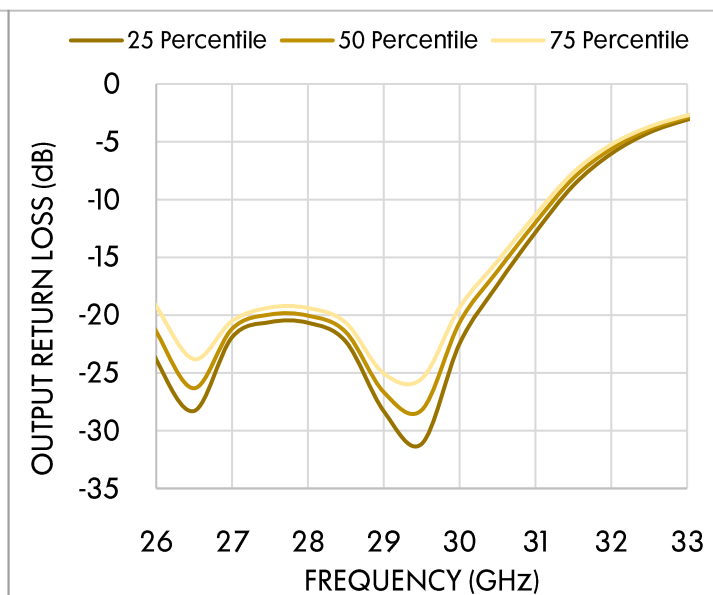
#### Large Signal PAE, Gain, PSAT vs. Frequency



#### Input Return Loss vs. Frequency



#### Output Return Loss vs. Frequency



# APN229

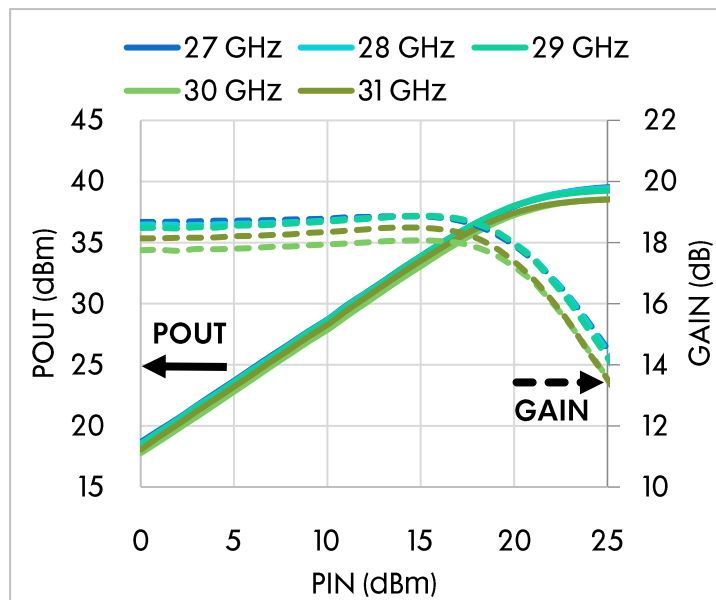
## 27 – 31 GHz

### GaN Power Amplifier

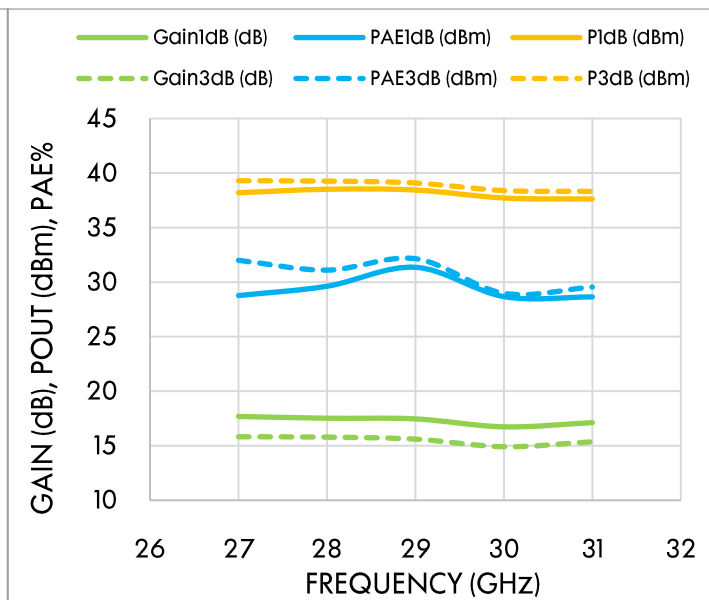
Fixture measured Performance Characteristics (Typical Performance at 25°C)

$V_d = 28.0\text{ V}$ ,  $I_{d1} + I_{d1a} = 120\text{ mA}$ ,  $I_{d2} + I_{d2a} = 480\text{ mA}$ .

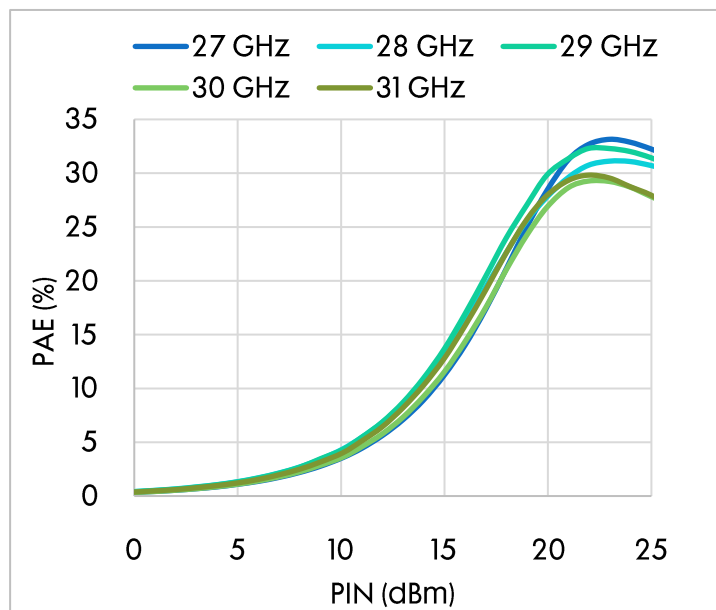
**POUT and Gain vs. PIN**



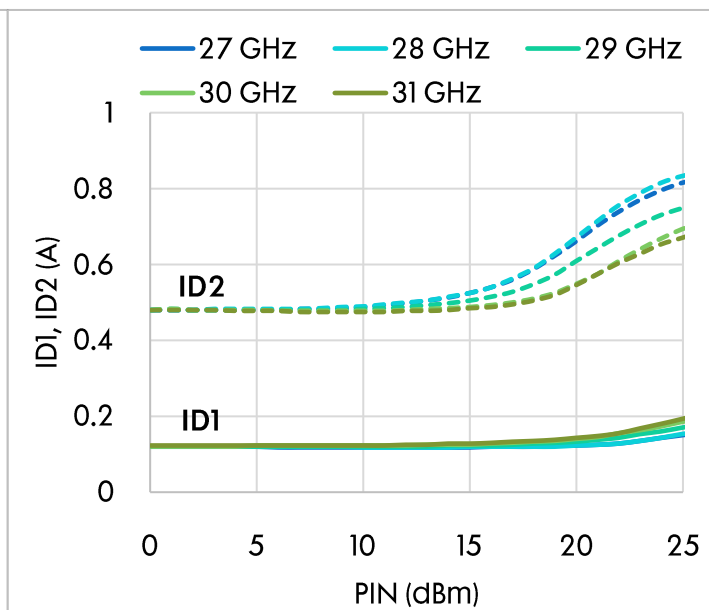
**PAE, Gain, POUT vs. Frequency**



**PAE vs. PIN**



**ID1, ID2 vs. PIN**



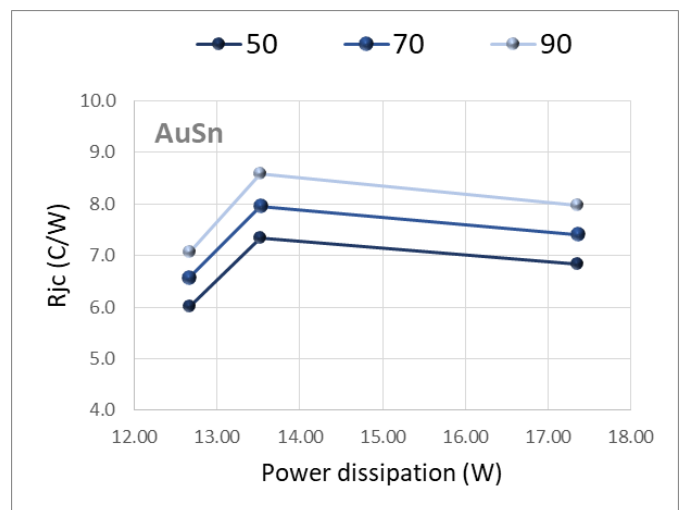
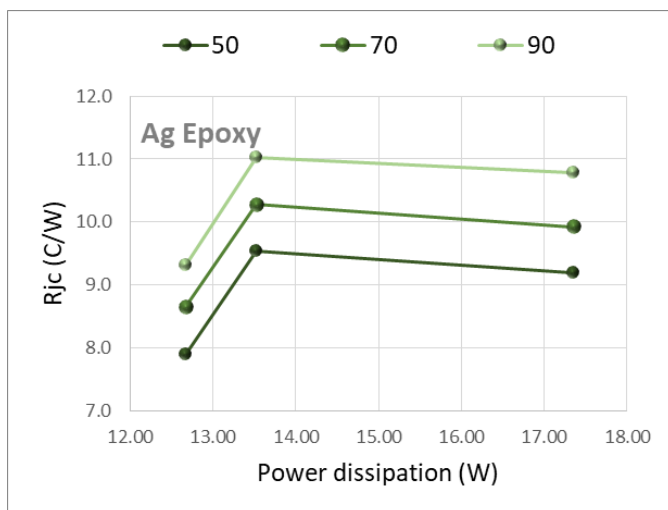
# APN229

## 27 – 31 GHz

### GaN Power Amplifier

Preliminary Thermal Properties with die mounted with 25 um 80/20 AuSn Eutectic \*\* to: 10 mil CuW10 Shim

Shim	Mounting Material	Average Backside Die Temperature	Hottest Junction Temperature T <sub>jc</sub>	RF Output (dBm)	Power Dissipation (W)	Thermal Resistance R <sub>jc</sub> (°C/W)
10 mil CuW	AuSn Eutectic	30 °C	126.1	32.98	12.67	6.0
			149.2	36.4	13.52	7.3
			168.8	39.25	17.36	6.8
		50 °C	153.2	32.98	12.67	6.6
			177.6	36.4	13.52	8.0
			198.6	39.25	17.36	7.4
		70 °C	179.5	32.98	12.67	7.1
			206.1	36.4	13.52	8.6
			228.3	39.25	17.36	8.0
10 mil CuW	Silver Epoxy	30 °C	149.9	32.98	12.67	7.9
			179.0	36.4	13.52	9.5
			209.4	39.25	17.36	9.2
		50 °C	179.6	32.98	12.67	8.7
			208.9	36.4	13.52	10.3
			242.2	39.25	17.36	9.9
		70 °C	239.1	33.2	12.67	9.3
			208.1	36.4	13.52	11.0
			277.1	39.25	17.36	10.8



\*\* V<sub>d</sub> = 28.0 V, I<sub>dq</sub> = 120 mA, I<sub>d2q</sub> = 480 mA

Page 5

[www.ngc.com](http://www.ngc.com)

[www.ngc.com/what-we-do/microelectronics-space-park/](http://www.ngc.com/what-we-do/microelectronics-space-park/)

Phone: (310) 814-5000 • Fax: (310) 812-7011 • Email: [asmpsales@ngc.com](mailto:asmpsales@ngc.com)

Approved for Public Release: NG24-1054. © 2024 Northrop Grumman Systems Corporation

© Northrop Grumman Systems Corporation

Preliminary Information: The data contained in this document describes new products in the sampling or preproduction phase of development and is for information only. Northrop Grumman reserves the right to change without notice the characteristics data and other specifications as they apply to this product. The product represented by this datasheet is subject to the U.S. Export Law as contained in the EAR regulations.



# APN229

## 27 – 31 GHz

### GaN Power Amplifier

#### DIE SIZE AND BOND PAD LOCATIONS

X = 3650  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

Y = 2030  $\pm$  25  $\mu\text{m}$

DC Bond Pad = 100 x 100  $\pm$  0.5  $\mu\text{m}$

RF Bond Pad = 100 x 100  $\pm$  0.5  $\mu\text{m}$

Chip Thickness = 101  $\pm$  5  $\mu\text{m}$

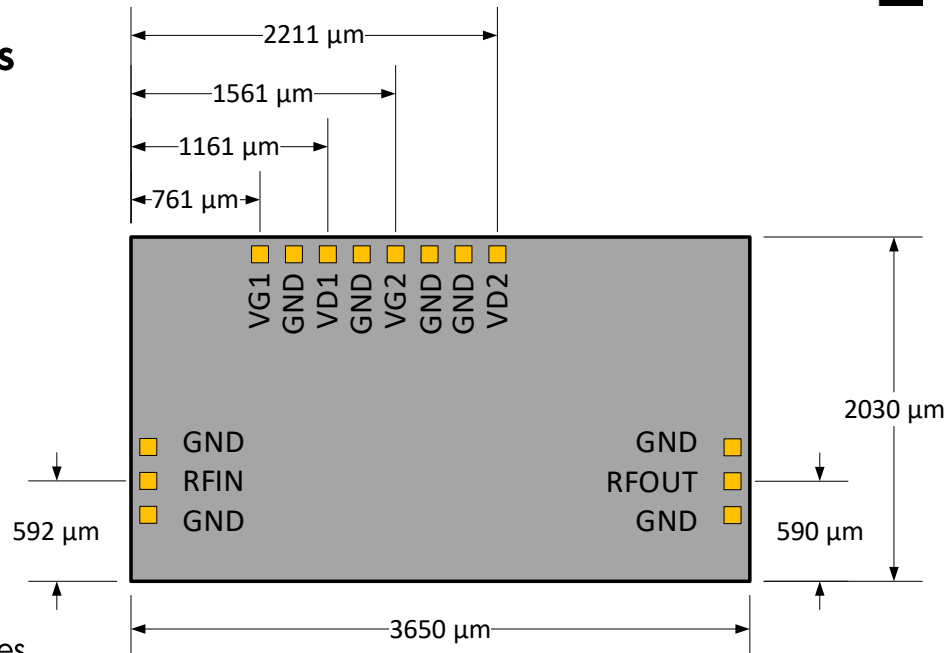
#### BIASING/DE-BIASING DETAILS:

Bias for 1<sup>st</sup> stage is from top.

The 2<sup>nd</sup> stages must bias up from both sides.

Listed below are some guidelines for GaN device testing and wire bonding:

- a. Limited positive gate bias (G-S or G-D) to < 1V
- b. Know your devices' breakdown voltages
- c. Use a power supply with both voltage and current limit
- d. With the power supply off and the voltage and current levels at minimum, attach the ground lead to your test fixture
  - a. Apply negative gate voltage (-8 V) to ensure that all devices are off
  - b. Ramp up drain bias to ~10 V
  - c. Gradually increase gate bias voltage while monitoring drain current until 20% of the operating current is achieved
  - d. Ramp up drain to operating bias
  - e. Gradually increase gate bias voltage while monitoring drain current until the operating current is achieved
- e. To safely de-bias GaN devices, start by de-biasing output amplifier stages first (if applicable):
  - a. Set gate voltage back to pinch-off (-8 V)
  - b. Gradually decrease drain bias to 0 V
  - c. Gradually decrease gate bias to 0 V
  - d. Turn off supply voltages
- f. Repeat de-bias procedure for each amplifier stage



Page 6

[www.ngc.com](http://www.ngc.com)

[www.ngc.com/what-we-do/microelectronics-space-park/](http://www.ngc.com/what-we-do/microelectronics-space-park/)

Phone: (310) 814-5000 • Fax: (310) 812-7011 • Email: [asmpsales@ngc.com](mailto:asmpsales@ngc.com)  
 Approved for Public Release: NG24-1054. © 2024 Northrop Grumman Systems Corporation

© Northrop Grumman Systems Corporation  
 Preliminary Information: The data contained in this document describes new products in the sampling or preproduction phase of development and is for information only. Northrop Grumman reserves the right to change without notice the characteristics data and other specifications as they apply to this product. The product represented by this datasheet is subject to the U.S. Export Law as contained in the EAR regulations.

**NORTHROP  
GRUMMAN**

# APN229

## 27 – 31 GHz

### GaN Power Amplifier



#### TAB-DIE SIZE AND BOND PAD LOCATIONS

##### CuMoCu-based Tab

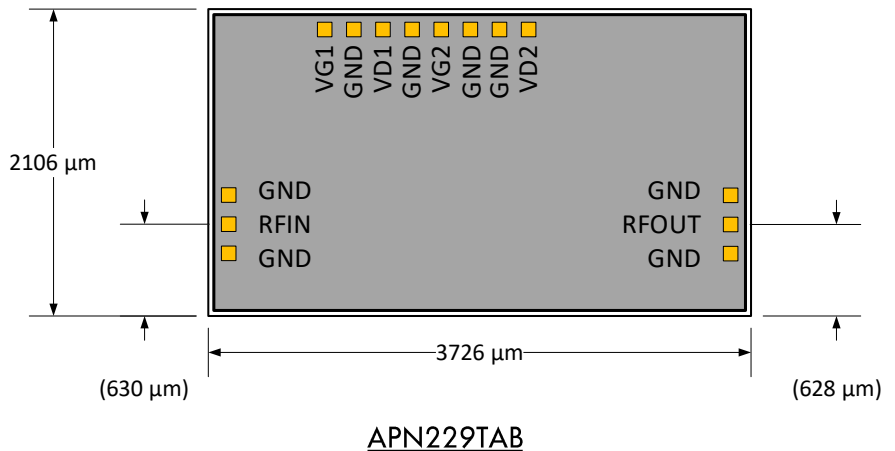
X = 3726  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

Y = 2106  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

Tab Thickness = 254  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

##### Eutectic Solder layer

Eutectic Thickness = 1 mil (25  $\mu\text{m}$ ) nominal



#### TAB-CAPACITOR-DIE SIZE AND BOND PAD LOCATIONS

##### CuMoCu-based Tab + Capacitors

X = 3726  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

Y = 6360  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

Tab Thickness = 254  $\mu\text{m}$   $\pm$  25  $\mu\text{m}$

##### Eutectic Solder layer

Eutectic Thickness = 1 mil (25  $\mu\text{m}$ ) nominal

##### 100pF, 100V Bar Capacitors

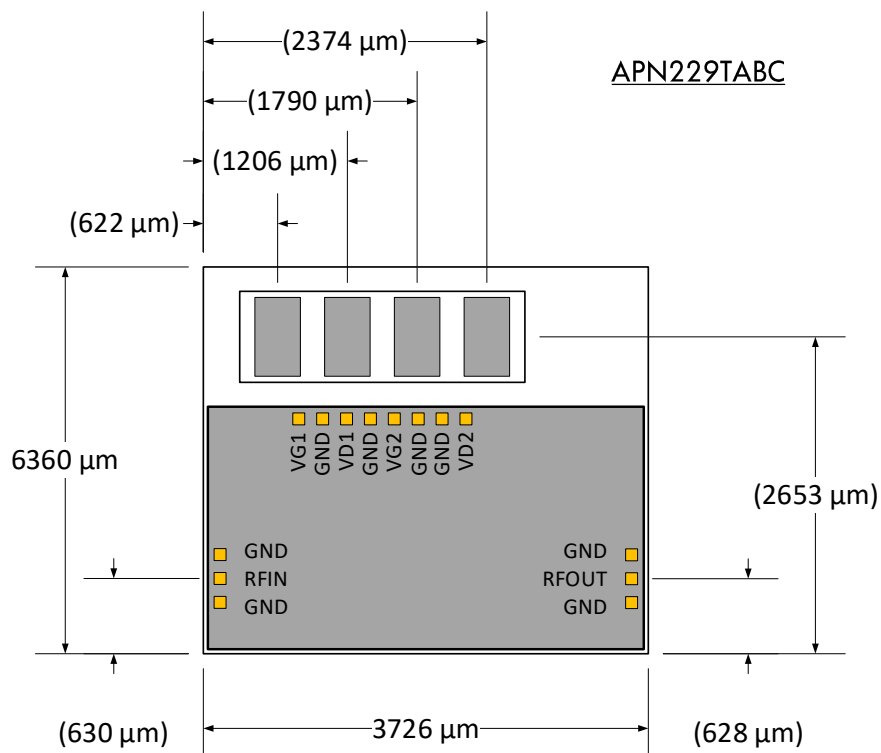
X = 2388  $\mu\text{m}$   $\pm$  76  $\mu\text{m}$

Y = 762  $\mu\text{m}$   $\pm$  76  $\mu\text{m}$

DC Gold Bond Pad = 381 x 660  $\mu\text{m}$  nominal

Cap Thickness = 127  $\mu\text{m}$   $\pm$  38  $\mu\text{m}$

Cap Part Number = CRM-BN-94X30X5-G-101-Z-CE396 (or equivalent)



# APN229

## 27 – 31 GHz

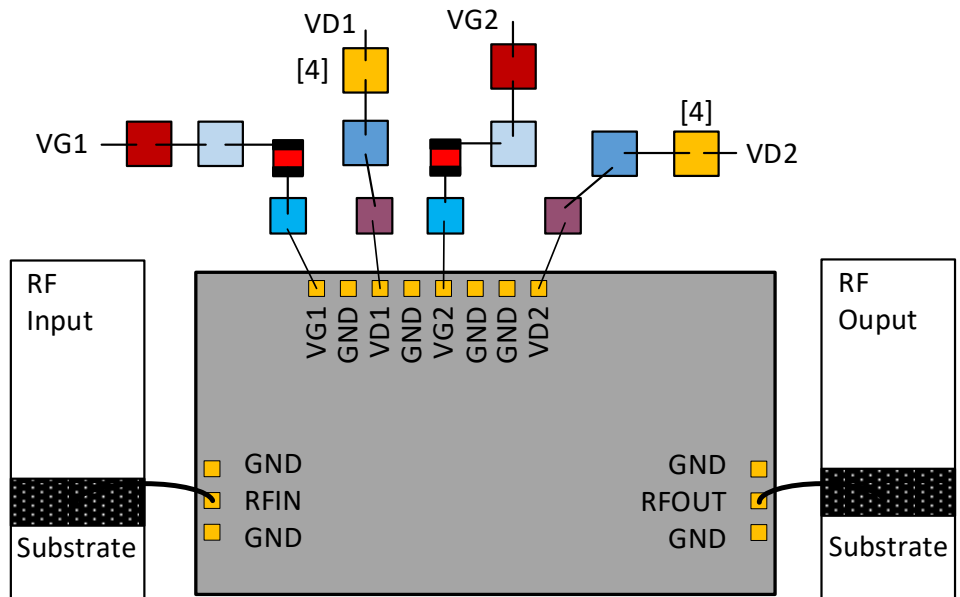
### GaN Power Amplifier










#### RECOMMENDED ASSEMBLY NOTES

1. Bypass caps should be 100 pF (approximately) ceramic (single-layer) placed no farther than 30 mils from the amplifier.
2. Best performance obtained from use of <10 mil (long) by 3 by 0.5 mil ribbons on input and output.
3. Part must be biased from both sides as indicated.
4. The 0.1uF, 50V capacitors are not needed if the drain supply line is clean. If Drain Pulsing of the device is to be used, do **NOT** use the 0.1uF, 50V Capacitors.

#### SUGGESTED BONDING ARRANGEMENT



#### GENERAL DIAGRAM SYMBOLS

	= 0.1 uF, 50V (Shunt) [4]		= 0.1 uF, 15V (Shunt)		= 100 pF, 50V (Shunt)
	= 0.01 uF, 50V (Shunt)		= 0.01 uF, 15V (Shunt)		= 100 pF, 15V (Shunt)
					= 10 Ohms, 30V (Series)

#### MOUNTING PROCESSES

Most NGSS GaN IC chips have a gold backing and can be mounted successfully using either a conductive epoxy or AuSn attachment. NGSS recommends the use of AuSn for high power devices to provide a good thermal path and a good RF path to ground. Maximum recommended temp during die attach is 320 °C for 30 seconds.

Note: Many of the NGSS parts do incorporate airbridges, so caution should be used when determining the pickup tool.

**CAUTION: THE IMPROPER USE OF AuSn ATTACHMENT CAN CATASTROPHICALLY DAMAGE GaN CHIPS.**

**PLEASE ALSO REFER TO OUR "GaN Chip Handling Application Note" BEFORE HANDLING, ASSEMBLING OR BIASING THESE MMICS!**



# APN229

## 27 – 31 GHz

### GaN Power Amplifier

#### GENERAL CHIP DIAGRAM FOR DIMENSIONING

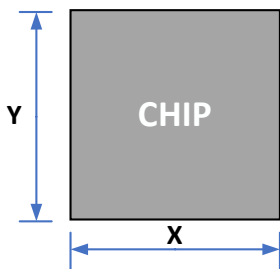


Figure A

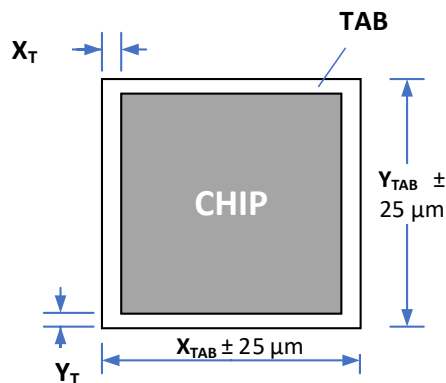


Figure B

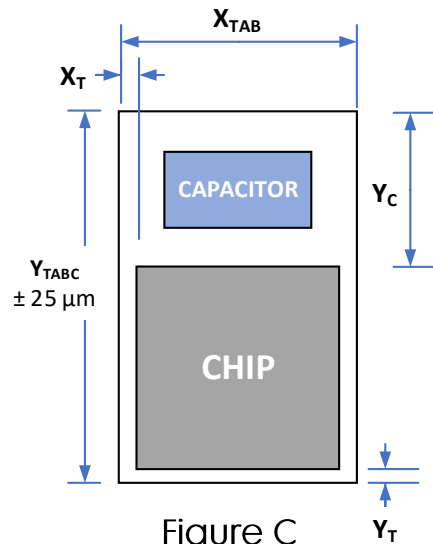


Figure C

#### SCHEMATIC LEGEND

Parameter	Value	Tolerance
Chip Width (X)	See Die Size Page	See Die Size Page
Chip Length (Y)	See Die Size Page	See Die Size Page
Tab-Chip Width Offset ( $X_T$ )	38 $\mu\text{m}$ (0.0015")	-
Tab-Chip Length Offset ( $Y_T$ )	38 $\mu\text{m}$ (0.0015")	-
TAB Width ( $X_{TAB}$ )	$X_{TAB} = X + 76 \mu\text{m}$	$\pm 25 \mu\text{m}$
TAB Length ( $Y_{TAB}$ )	$Y_{TAB} = Y + 76 \mu\text{m}$	$\pm 25 \mu\text{m}$
TAB Length ( $Y_{TABC}$ )	$Y_{TABC} = Y + Y_C + Y_T$	$\pm 25 \mu\text{m}$
Chip Edge to TAB Edge Length ( $Y_C$ )	1170 $\mu\text{m}$ (0.046")	-

#### NOTES

Figure A: Chip

Figure B: Chip + Heat Spreader (TAB)

Figure C: Chip + Heat Spreader (TAB) + Capacitor

- Chip Width and Length vary depending on product dimensions

- Each Parameter has its own respective tolerance that is shown throughout the data sheet

- Figures B and C have the same Width ( $X_{TAB}$ )

# APN229

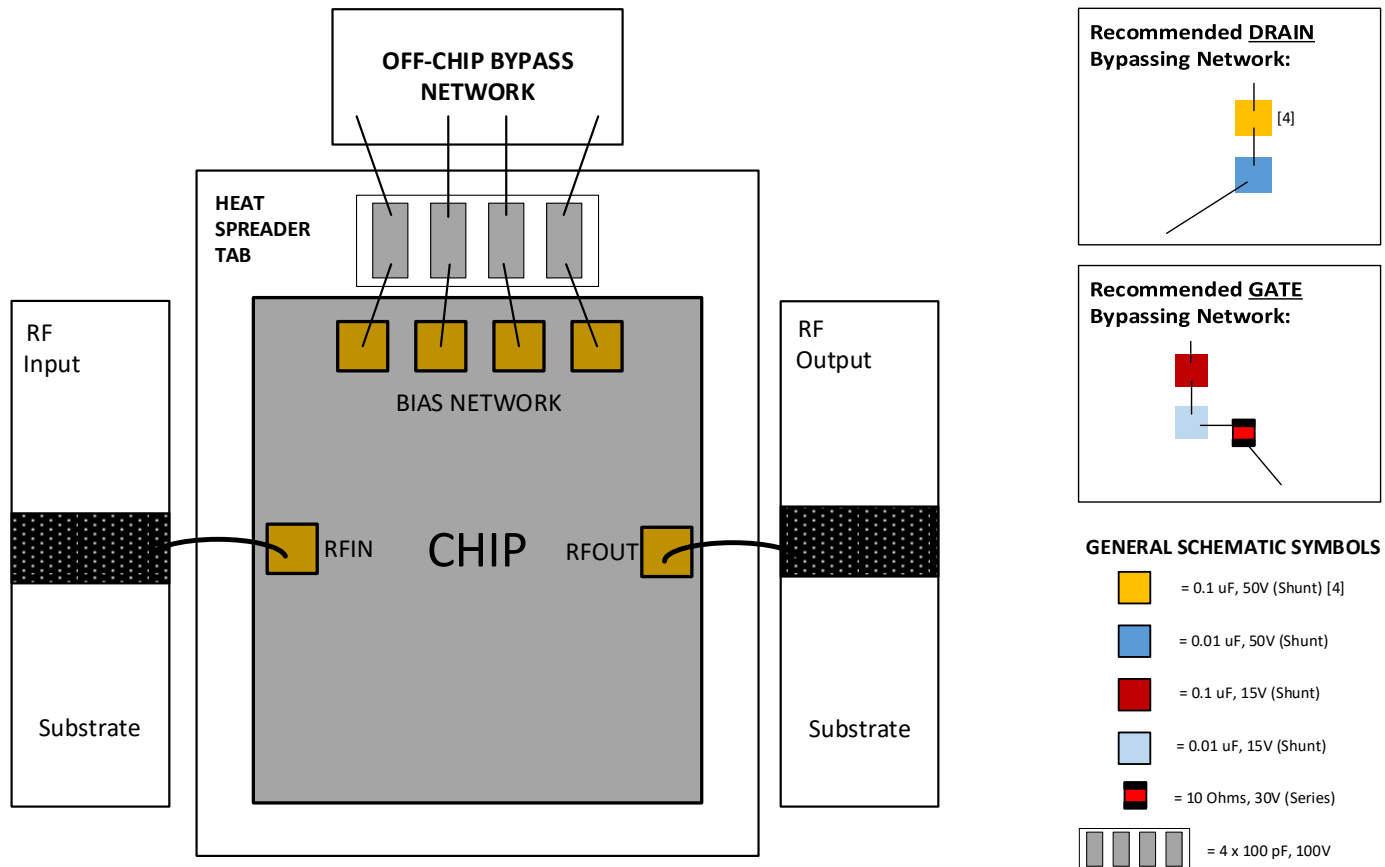
## 27 – 31 GHz

### GaN Power Amplifier

#### GENERAL BONDING ARRANGEMENT FOR FIGURE C

\*\* BELOW LAYOUT SHOWS BONDING ARRANGEMENT OF A GENERIC AMPLIFIER FOR REFERENCE

\*\* SPECIFIC BYPASS INTERCONNECTIONS DRIVEN BY RESPECTIVE CHIP



#### DIAGRAM NOTES

- The 100 pF (15V & 50V) capacitors shown in the “SUGGESTED BONDING ARRANGEMENT” Bare Die diagram are replaced with 100 pF (100V) Bar Capacitors for the Capacitor TAB configuration
- The remaining capacitors/resistors previously shown in “SUGGESTED BONDING ARRANGEMENT” are the same and now connect to the Bar Capacitors
- Best performance obtained from use of <10 mil (long) by 3 by 0.5 mil ribbons on input and output.
- [4] The 0.1uF, 50V capacitors are not needed if the drain supply line is clean. If Drain Pulsing of the device is to be used, do **NOT** use the 0.1uF, 50V Capacitors.

**PLEASE ALSO REFER TO OUR “GaN Chip Handling Application Note” BEFORE HANDLING, ASSEMBLING OR BIASING THESE MMICS!**

Page 10

[www.ngc.com](http://www.ngc.com)

[www.ngc.com/what-we-do/microelectronics-space-park/](http://www.ngc.com/what-we-do/microelectronics-space-park/)

Phone: (310) 814-5000 • Fax: (310) 812-7011 • Email: [asmpsales@ngc.com](mailto:asmpsales@ngc.com)  
Approved for Public Release: NG24-1054. © 2024 Northrop Grumman Systems Corporation

© Northrop Grumman Systems Corporation  
Preliminary Information: The data contained in this document describes new products in the sampling or preproduction phase of development and is for information only. Northrop Grumman reserves the right to change without notice the characteristics data and other specifications as they apply to this product. The product represented by this datasheet is subject to the U.S. Export Law as contained in the EAR regulations.

**NORTHROP  
GRUMMAN**